

<b>Notice of References Cited</b>	Application/Control No. 10/804,144	Applicant(s)/Patent Under Reexamination TAKIZAWA ET AL.	
	Examiner Susan W. Berman	Art Unit 1711	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,852,766	02-2005	DeVoe, Robert J.	522/25
	B	US-2003/0052311	03-2003	Inagaki et al.	252/600
	C	US-			
	D	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

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